

## [\*\*Lazarenko Petr\*\*](#)

Teze/Rezumate în culegeri - [1](#).

**2017 - 1**

**Investigation of the crystallization kinetics for Ge<sub>2</sub>Sb<sub>2</sub>Te<sub>5</sub> thin films by differential scanning calorimetry and measurements of the resistivity temperature dependences**

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